

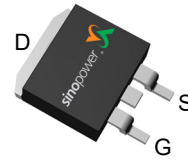
### Features

- 200V/110A  
 $R_{DS(ON)}=11m\Omega(max.)@V_{GS}=10V$
- 100% UIS +  $R_g$  Tested
- Reliable and Rugged
- Lead Free and Green Devices Available  
 (RoHS Compliant)
- Moisture Sensitivity Level MSL1  
 (per JEDEC J-STD-020D)

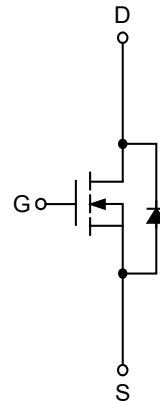
### Applications

- Synchronous Rectification.
- Power Management in Inverter Systems.
- DC/DC Converter.

### Pin Description

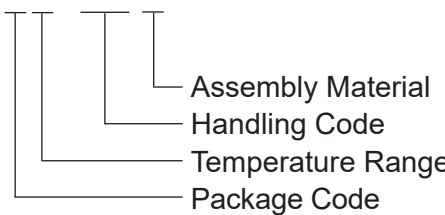



TO-263-2



N-Channel MOSFET

### Ordering and Marking Information

|  |  |
|--|--|
| <p>SM2A50NH □□-□□ □</p>  <p>Assembly Material<br/>         Handling Code<br/>         Temperature Range<br/>         Package Code</p> | <p>Package Code<br/>         G : TO-263-2<br/>         Operating Junction Temperature Range<br/>         D : -55 to 175 °C<br/>         Handling Code<br/>         TR : Tape &amp; Reel<br/>         Assembly Material<br/>         G : Halogen and Lead Free Device</p> |
| <p>SM2A50NH G :</p>  |  <p>XXXXX - Lot Code</p>  |

Note : SINOPOWER lead-free products contain molding compounds/die attach materials and 100% matte tin plate termination finish; which are fully compliant with RoHS. SINOPOWER lead-free products meet or exceed the lead-free requirements of IPC/JEDEC J-STD-020D for MSL classification at lead-free peak reflow temperature. SINOPOWER defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

SINOPOWER reserves the right to make changes to improve reliability or manufacturability without notice, and advise customers to obtain the latest version of relevant information to verify before placing orders.

**Absolute Maximum Ratings** ( $T_A=25^{\circ}\text{C}$  Unless Otherwise Noted)

| Symbol                | Parameter                              | Rating                           | Unit                        |
|-----------------------|--|----------------------------------|-----------------------------|
| <b>Common Ratings</b> |  |                                  |                             |
| $V_{DSS}$             | Drain-Source Voltage                   | 200                              | V                           |
| $V_{GSS}$             | Gate-Source Voltage                    | $\pm 20$                         |                             |
| $T_J$                 | Maximum Junction Temperature           | 175                              | $^{\circ}\text{C}$          |
| $T_{STG}$             | Storage Temperature Range              | -55 to 175                       |                             |
| $I_S$                 | Diode Continuous Forward Current       | $T_C=25^{\circ}\text{C}$<br>55   | A                           |
| $I_D$                 | Continuous Drain Current               | $T_C=25^{\circ}\text{C}$<br>110  |                             |
|                       | Continuous Drain Current               | $T_C=100^{\circ}\text{C}$<br>78  |                             |
| $I_{DM}^a$            | Pulsed Drain Current                   | $T_C=25^{\circ}\text{C}$<br>330  |                             |
| $P_D$                 | Maximum Power Dissipation              | $T_C=25^{\circ}\text{C}$<br>375  | W                           |
|                       |  | $T_C=100^{\circ}\text{C}$<br>187 |                             |
| $R_{\theta JC}$       | Thermal Resistance-Junction to Case    | 0.4                              | $^{\circ}\text{C}/\text{W}$ |
| $I_D$                 | Continuous Drain Current               | $T_A=25^{\circ}\text{C}$<br>9.8  | A                           |
|                       |  | $T_A=70^{\circ}\text{C}$<br>8.2  |                             |
| $P_D$                 | Maximum Power Dissipation              | $T_A=25^{\circ}\text{C}$<br>3    | W                           |
|                       |  | $T_A=70^{\circ}\text{C}$<br>2.1  |                             |
| $R_{\theta JA}^c$     | Thermal Resistance-Junction to Ambient | 50                               | $^{\circ}\text{C}/\text{W}$ |
| $I_{AS}^b$            | Avalanche Current, Single pulse        | $L=0.5\text{mH}$<br>33           | A                           |
| $E_{AS}^b$            | Avalanche Energy, Single pulse         | $L=0.5\text{mH}$<br>272          | mJ                          |

Note a : Pulse width limited by maximum junction temperature.

Note b : UIS tested and pulse width limited by maximum junction temperature (initial temperature  $T_J=25^{\circ}\text{C}$ ).

Note c : Surface Mounted on  $1\text{in}^2$  pad area.

**Electrical Characteristics** ( $T_A = 25^\circ\text{C}$  unless otherwise noted)

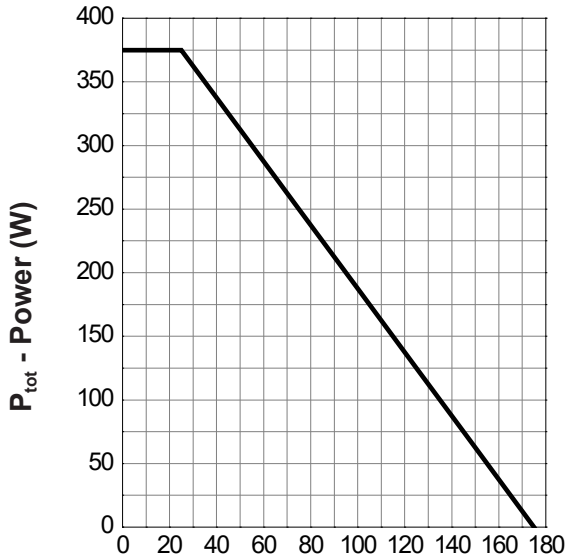
| Symbol  | Parameter                        | Test Conditions                                    | Min.  | Typ. | Max.      | Unit      |
|---|----------------------------------|--|---|------|-----------|-----------|
| <b>Static Characteristics</b>                   |                                  |  |   |      |           |           |
| $BV_{DSS}$                                      | Drain-Source Breakdown Voltage   | $V_{GS}=0V, I_{DS}=250\mu A$                       | 200   | -    | -         | V         |
| $I_{DSS}$                                       | Zero Gate Voltage Drain Current  | $V_{DS}=160V, V_{GS}=0V$                           | -   | -    | 1         | $\mu A$   |
|   |                                  | $T_J=85^\circ C$                                   | -   | -    | 30        |           |
| $V_{GS(th)}$                                    | Gate Threshold Voltage           | $V_{DS}=V_{GS}, I_{DS}=250\mu A$                   | 2   | 3    | 4         | V         |
| $I_{GSS}$                                       | Gate Leakage Current             | $V_{GS}=\pm 20V, V_{DS}=0V$                        | -   | -    | $\pm 100$ | nA        |
| $R_{DS(ON)}^d$                                  | Drain-Source On-state Resistance | $V_{GS}=10V, I_{DS}=50A$                           | -   | 10   | 11        | $m\Omega$ |
| <b>Diode Characteristics</b>                    |                                  |  |   |      |           |           |
| $V_{SD}^d$                                      | Diode Forward Voltage            | $I_{SD}=25A, V_{GS}=0V$                            | -   | 0.8  | 1.1       | V         |
| $t_{rr}^e$                                      | Reverse Recovery Time            | $I_{SD}=25A, di_{SD}/dt=100A/\mu s$                | -   | 125  | -         | ns        |
| $Q_{rr}^e$                                      | Reverse Recovery Charge          |  | -   | 662  | -         | nC        |
| <b>Dynamic Characteristics</b> <sup>e</sup>     |                                  |  |   |      |           |           |
| $R_G$   | Gate Resistance                  | $V_{GS}=0V, V_{DS}=0V, F=1MHz$                     | -   | 2    | -         | $\Omega$  |
| $C_{iss}$                                       | Input Capacitance                | $V_{GS}=0V,$<br>$V_{DS}=100V,$<br>Frequency=1.0MHz | -   | 6830 | 8880      | pF        |
| $C_{oss}$                                       | Output Capacitance               |  | -   | 367  | -         |           |
| $C_{riss}$                                      | Reverse Transfer Capacitance     |  | -   | 46   | -         |           |
| $t_{d(ON)}$                                     | Turn-on Delay Time               |  | $V_{DD}=30V, R_L=30\Omega,$<br>$I_{DS}=1A, V_{GEN}=10V,$<br>$R_G=6\Omega$ | -    | 41        | 74        |
| $t_r$   | Turn-on Rise Time                | -  |   | 25   | 45        |           |
| $t_{d(OFF)}$                                    | Turn-off Delay Time              | -  |   | 94   | 170       |           |
| $t_f$   | Turn-off Fall Time               | -  |   | 220  | 400       |           |
| <b>Gate Charge Characteristics</b> <sup>e</sup> |                                  |  |   |      |           |           |
| $Q_g$   | Total Gate Charge                | $V_{DS}=100V, V_{GS}=10V,$<br>$I_{DS}=50A$         | -   | 100  | 140       | nC        |
| $Q_{gs}$  | Gate-Source Charge               |  | -   | 37   | -         |           |
| $Q_{gd}$  | Gate-Drain Charge                |  | -   | 21   | -         |           |

Note d : Pulse test ; pulse width $\leq 300\mu s$ , duty cycle $\leq 2\%$ .

Note e : Guaranteed by design, not subject to production testing.

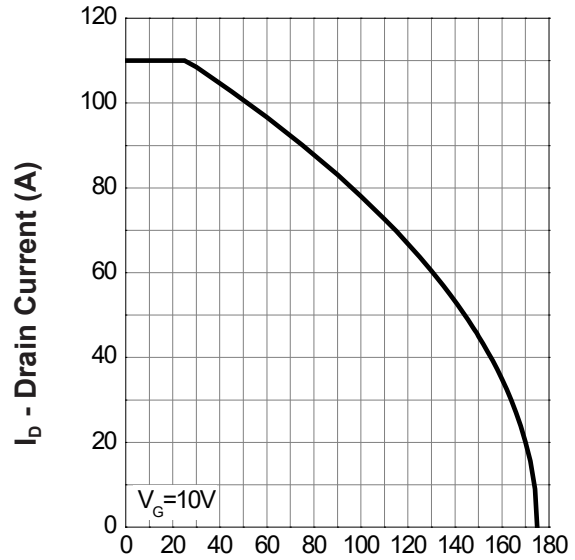
Typical Operating Characteristics

Power Dissipation



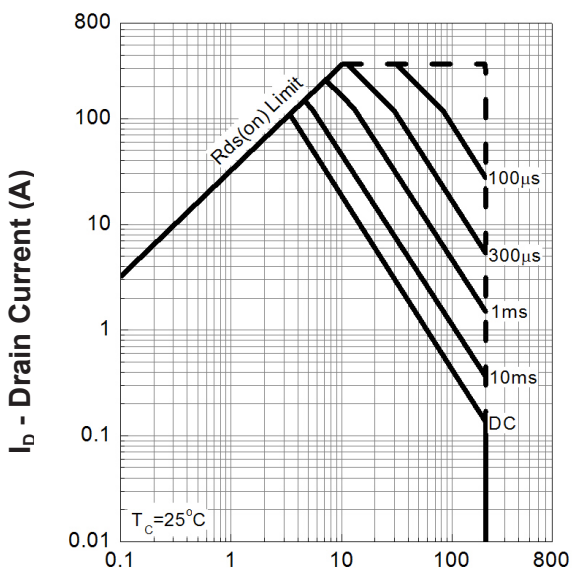
T<sub>c</sub> - Case Temperature (°C)

Drain Current



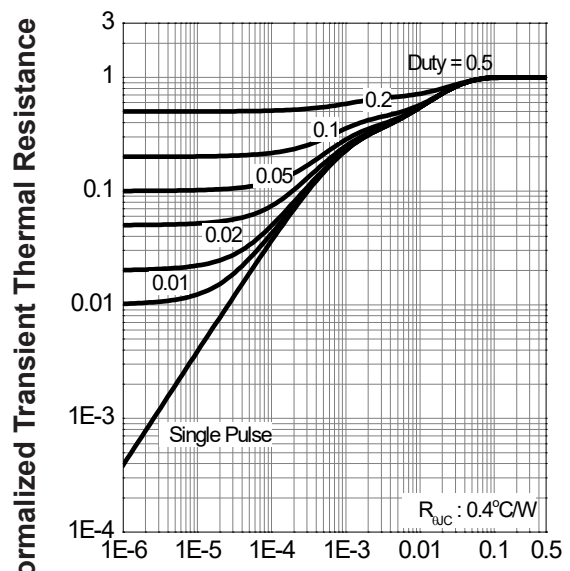
T<sub>c</sub> - Case Temperature (°C)

Safe Operation Area



V<sub>DS</sub> - Drain - Source Voltage (V)

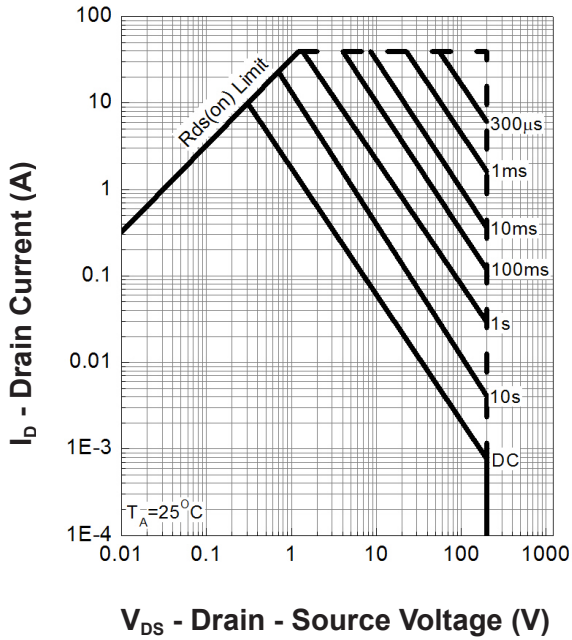
Thermal Transient Impedance



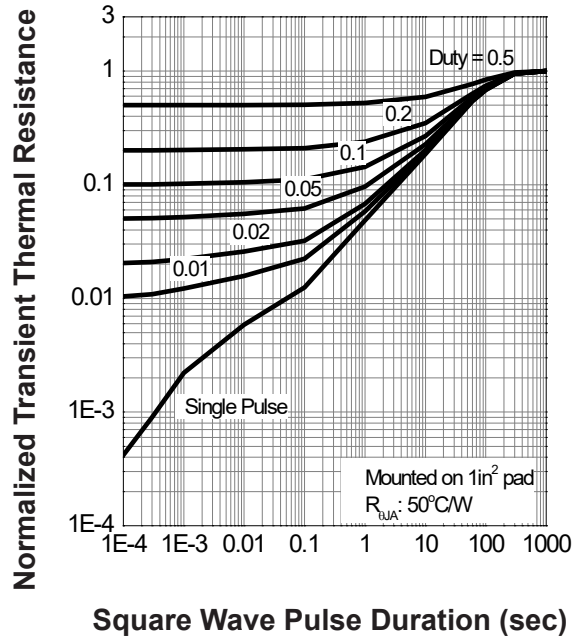
Square Wave Pulse Duration (sec)

Typical Operating Characteristics(Cont.)

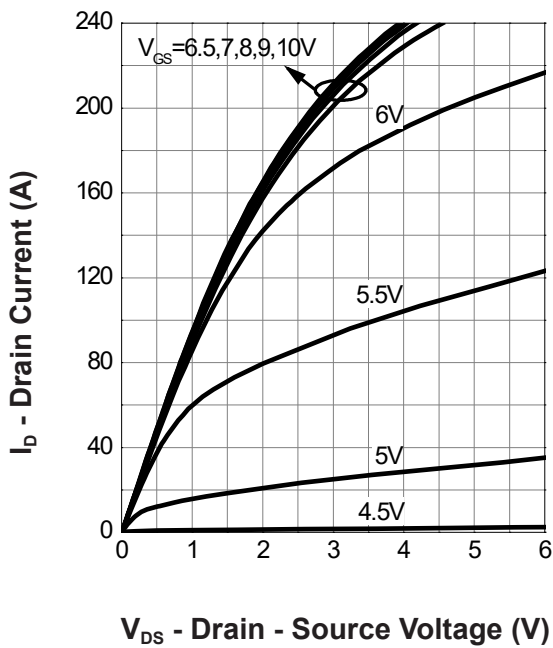
Safe Operation Area



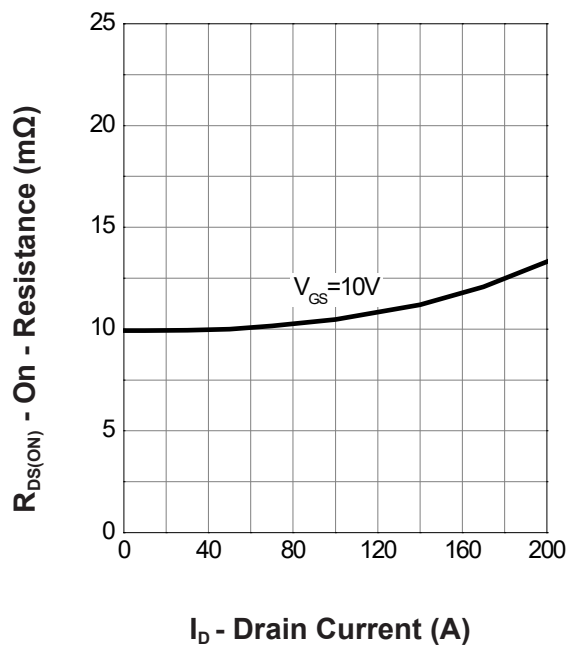
Thermal Transient Impedance



Output Characteristics

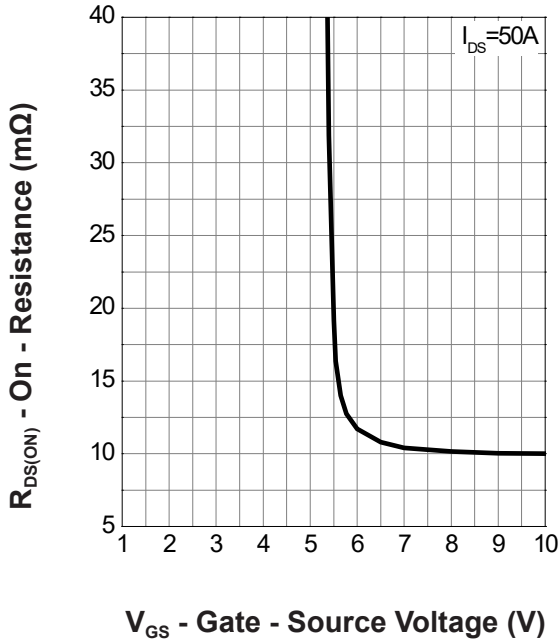


Drain-Source On Resistance

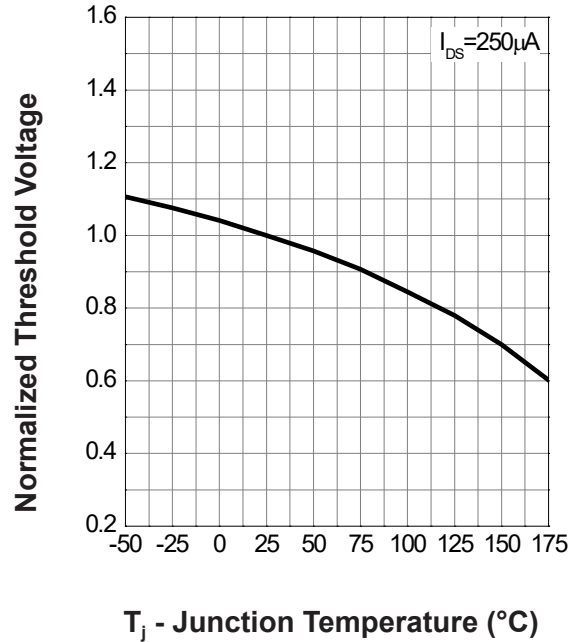


Typical Operating Characteristics(Cont.)

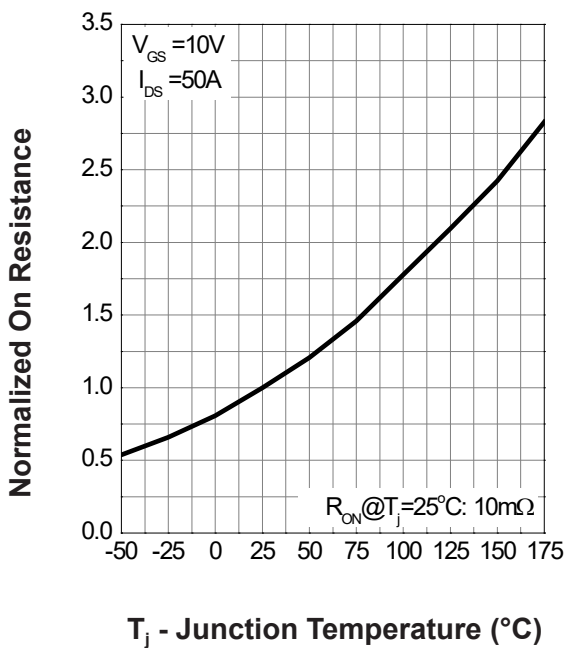
Gate-Source On Resistance



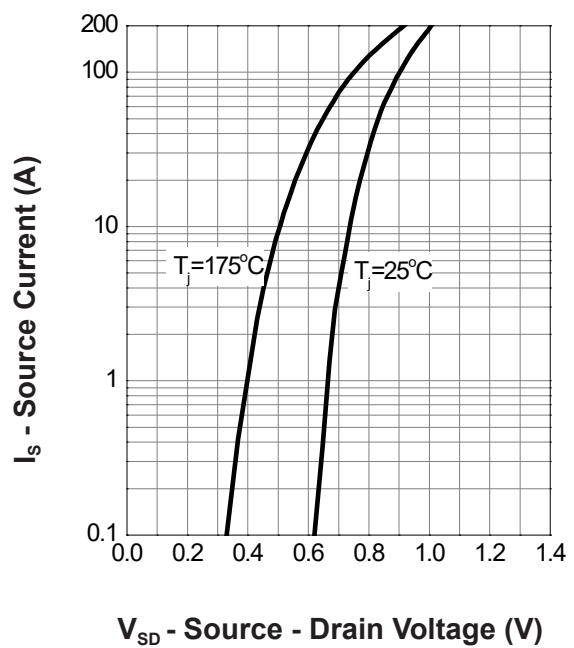
Gate Threshold Voltage



Drain-Source On Resistance

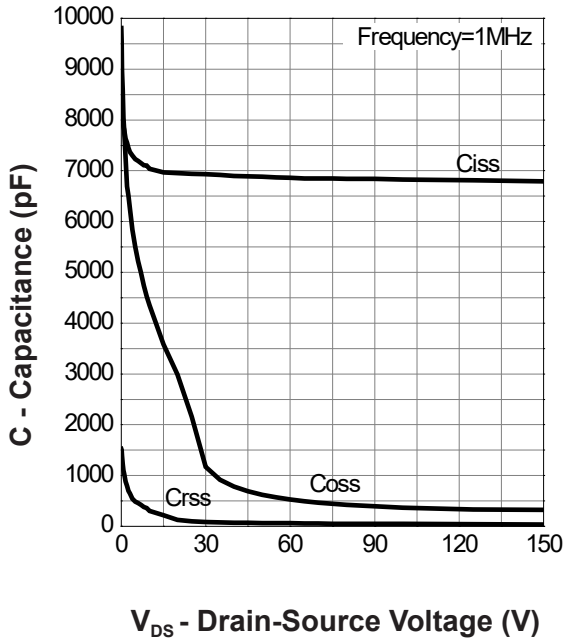


Source-Drain Diode Forward

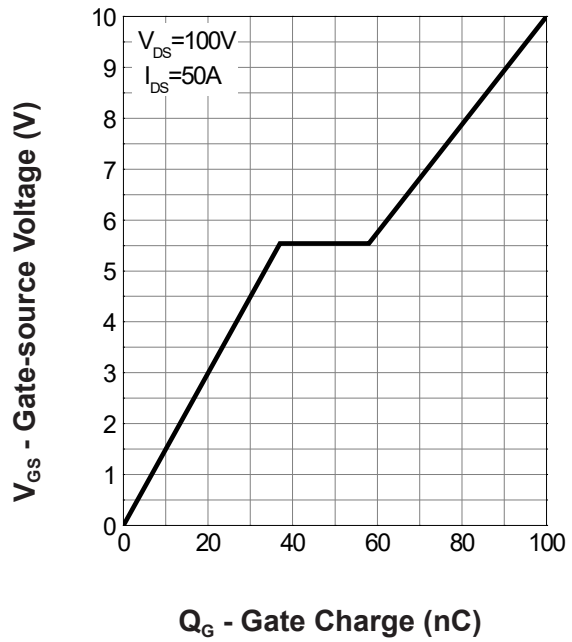


Typical Operating Characteristics(Cont.)

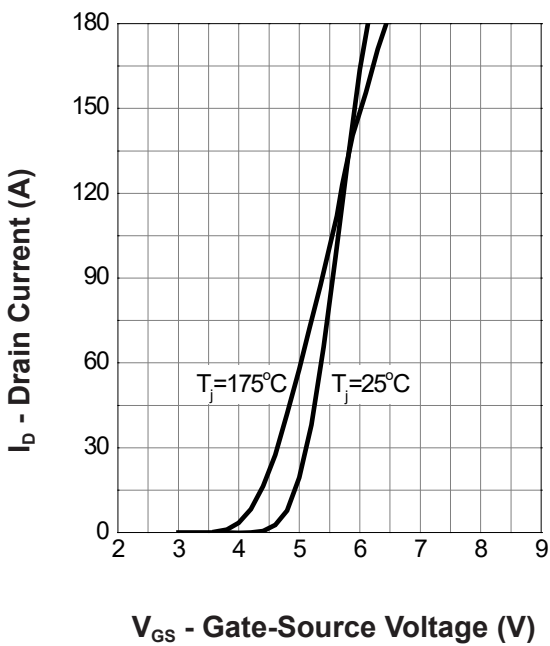
Capacitance



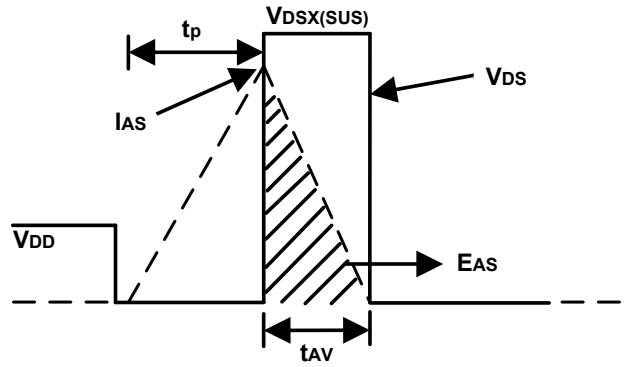
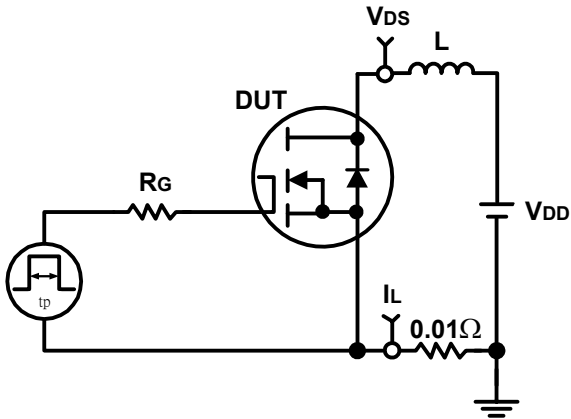
Gate Charge



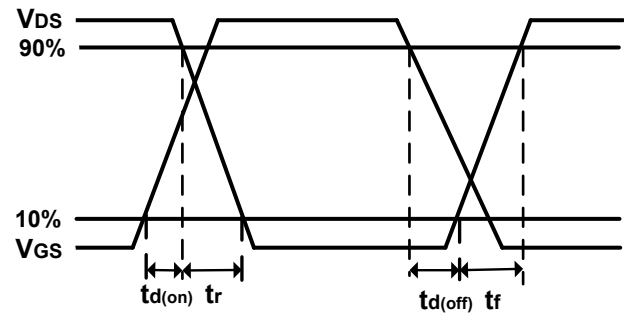
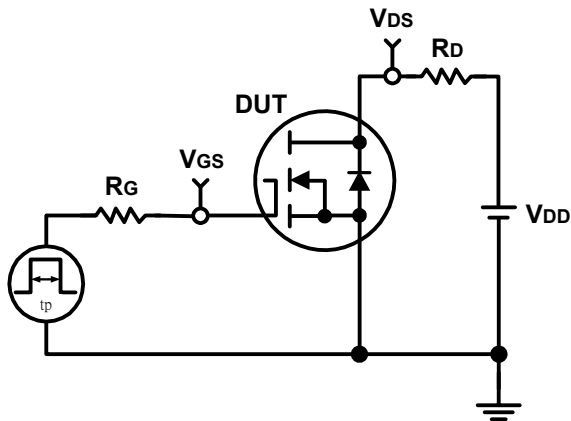
Transfer Characteristics



Avalanche Test Circuit and Waveforms



Switching Time Test Circuit and Waveforms





## Disclaimer

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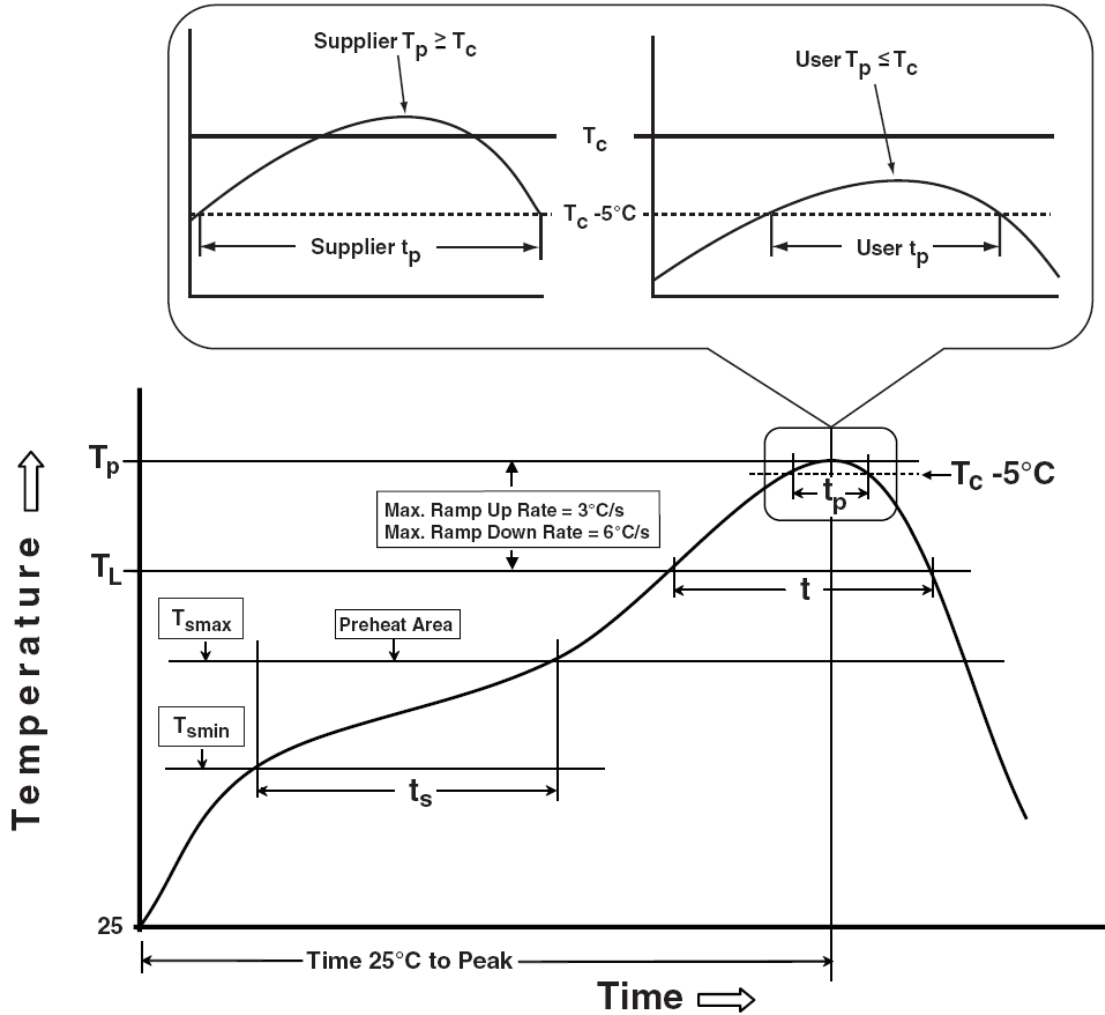
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In order to unify the quality and performance, Sinopower has been following JEDEC while defines assembly rule. Notwithstanding all the suppliers basically follow the rule for each product, different processes may cause slightly different results.

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Classification Profile



## Classification Reflow Profiles

| Profile Feature  | Sn-Pb Eutectic Assembly            | Pb-Free Assembly                   |
|--|------------------------------------|------------------------------------|
| <b>Preheat &amp; Soak</b>  |                                    |                                    |
| Temperature min ( $T_{smin}$ )   | 100 °C                             | 150 °C                             |
| Temperature max ( $T_{smax}$ )   | 150 °C                             | 200 °C                             |
| Time ( $T_{smin}$ to $T_{smax}$ ) ( $t_s$ )  | 60-120 seconds                     | 60-120 seconds                     |
| Average ramp-up rate ( $T_{smax}$ to $T_p$ )   | 3 °C/second max.                   | 3°C/second max.                    |
| Liquidous temperature ( $T_L$ )  | 183 °C                             | 217 °C                             |
| Time at liquidous ( $t_L$ )  | 60-150 seconds                     | 60-150 seconds                     |
| Peak package body Temperature ( $T_p$ )*   | See Classification Temp in table 1 | See Classification Temp in table 2 |
| Time ( $t_p$ )** within 5°C of the specified classification temperature ( $T_c$ )                                | 20** seconds                       | 30** seconds                       |
| Average ramp-down rate ( $T_p$ to $T_{smax}$ )   | 6 °C/second max.                   | 6 °C/second max.                   |
| Time 25°C to peak temperature  | 6 minutes max.                     | 8 minutes max.                     |
| * Tolerance for peak profile Temperature ( $T_p$ ) is defined as a supplier minimum and a user maximum.          |                                    |                                    |
| ** Tolerance for time at peak profile temperature ( $t_p$ ) is defined as a supplier minimum and a user maximum. |                                    |                                    |

Table 1. SnPb Eutectic Process – Classification Temperatures ( $T_c$ )

| Package Thickness | Volume mm <sup>3</sup> <350 | Volume mm <sup>3</sup> ≥350 |
|-------------------|-----------------------------|-----------------------------|
| <2.5 mm           | 235 °C                      | 220 °C                      |
| ≥2.5 mm           | 220 °C                      | 220 °C                      |

Table 2. Pb-free Process – Classification Temperatures ( $T_c$ )

| Package Thickness | Volume mm <sup>3</sup> <350 | Volume mm <sup>3</sup> 350-2000 | Volume mm <sup>3</sup> >2000 |
|-------------------|-----------------------------|---------------------------------|------------------------------|
| <1.6 mm           | 260 °C                      | 260 °C                          | 260 °C                       |
| 1.6 mm – 2.5 mm   | 260 °C                      | 250 °C                          | 245 °C                       |
| ≥2.5 mm           | 250 °C                      | 245 °C                          | 245 °C                       |

## Reliability Test Program

| Test item     | Method        | Description                            |
|---------------|---------------|--|
| SOLDERABILITY | JESD-22, B102 | 5 Sec, 245°C                           |
| HTRB          | JESD-22, A108 | 1000 Hrs, 80% of VDS max @ $T_{jmax}$  |
| HTGB          | JESD-22, A108 | 1000 Hrs, 100% of VGS max @ $T_{jmax}$ |
| PCT           | JESD-22, A102 | 168 Hrs, 100%RH, 2atm, 121°C           |
| TCT           | JESD-22, A104 | 500 Cycles, -65°C~150°C                |

## Customer Service

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